

## Silicon Carbide Junction Transistor/Schottky Diode Co-Pack

|                                       |   |        |
|---------------------------------------|---|--------|
| $V_{DS}$                              | = | 1200 V |
| $R_{DS(ON)}$                          | = | 20 mΩ  |
| $I_D$ ( $T_C = 25^\circ\text{C}$ )    | = | 80 A   |
| $I_D$ ( $T_C > 125^\circ\text{C}$ )   | = | 50 A   |
| $h_{FE}$ ( $T_C = 25^\circ\text{C}$ ) | = | 104    |

### Features

- 175 °C Maximum Operating Temperature
- Gate Oxide Free SiC Switch
- Exceptional Safe Operating Area
- Integrated SiC Schottky Rectifier
- Excellent Gain Linearity
- Temperature Independent Switching Performance
- Low Output Capacitance
- Positive Temperature Coefficient of  $R_{DS,ON}$
- Suitable for Connecting an Anti-parallel Diode

### Advantages

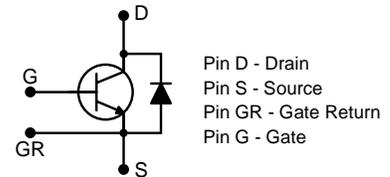
- Compatible with Si MOSFET/IGBT Gate Drive ICs
- > 20 μs Short-Circuit Withstand Capability
- Lowest-in-class Conduction Losses
- High Circuit Efficiency
- Minimal Input Signal Distortion
- High Amplifier Bandwidth
- Reduced cooling requirements
- Reduced system size

### Package

- RoHS Compliant



**SOT-227**



Please note: The Source and Gate Return pins are not exchangeable. Their exchange might lead to malfunction.

### Applications

- Down Hole Oil Drilling, Geothermal Instrumentation
- Hybrid Electric Vehicles (HEV)
- Solar Inverters
- Switched-Mode Power Supply (SMPS)
- Power Factor Correction (PFC)
- Induction Heating
- Uninterruptible Power Supply (UPS)
- Motor Drives

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### Section I: Absolute Maximum Ratings

| Parameter                         | Symbol    | Conditions  | Value   | Unit | Notes   |
|-----------------------------------|-----------|---|---|------|---------|
| <b>SiC Junction Transistor</b>    |           |   |   |      |         |
| Drain – Source Voltage            | $V_{DS}$  | $V_{GS} = 0\text{ V}$   | 1200  | V    |         |
| Continuous Drain Current          | $I_D$     | $T_C = 25^\circ\text{C}$  | 80  | A    | Fig. 12 |
| Continuous Drain Current          | $I_D$     | $T_C = 115^\circ\text{C}$   | 50  | A    | Fig. 12 |
| Continuous Gate Current           | $I_G$     |   | 3.5   | A    |         |
| Continuous Gate Return Current    | $I_{GR}$  |   | 3.5   | A    |         |
| Turn-Off Safe Operating Area      | RBSOA     | $T_{VJ} = 175^\circ\text{C}$ ,<br>Clamped Inductive Load  | $I_{D,max} = 50$<br>@ $V_{DS} \leq V_{DSmax}$ | A    | Fig. 14 |
| Short Circuit Safe Operating Area | SCSOA     | $T_{VJ} = 175^\circ\text{C}$ , $I_G = 1\text{ A}$ , $V_{DS} = 800\text{ V}$ ,<br>Non Repetitive | >20   | μs   |         |
| Reverse Gate – Source Voltage     | $V_{SG}$  |   | 30  | V    |         |
| Reverse Drain – Source Voltage    | $V_{SD}$  |   | 25  | V    |         |
| Power Dissipation                 | $P_{tot}$ | $T_C = 25^\circ\text{C} / 115^\circ\text{C}$ , $t_p > 100\text{ ms}$                            | 265 / 106                                     | W    | Fig. 11 |
| Operating and storage temperature | $T_{stg}$ |   | -55 to 175                                    | °C   |         |

| Parameter   | Symbol        | Conditions   | Value | Unit                 | Notes |
|---|---------------|--|-------|----------------------|-------|
| <b>Free-Wheeling SiC Diode</b>                          |               |  |       |                      |       |
| Repetitive peak reverse voltage                         | $V_{RRM}$     |  | 1200  | V                    |       |
| Continuous forward current                              | $I_F$         | $T_C \leq 115^\circ\text{C}$                       | 50    | A                    |       |
| RMS forward current                                     | $I_{F(RMS)}$  | $T_C \leq 115^\circ\text{C}$                       | 87    | A                    |       |
| Surge non-repetitive forward current,<br>Half Sine Wave | $I_{FSM}$     | $T_C = 25^\circ\text{C}$ , $t_p = 10\text{ ms}$    | 350   | A                    |       |
|   |               | $T_C = 115^\circ\text{C}$ , $t_p = 10\text{ ms}$   | 313   | A                    |       |
| Non-repetitive peak forward current                     | $I_{F,max}$   | $T_C = 25^\circ\text{C}$ , $t_p = 10\ \mu\text{s}$ | 1625  | A                    |       |
| $I^2t$ value  | $\int i^2 dt$ | $T_C = 25^\circ\text{C}$ , $t_p = 10\text{ ms}$    | 450   | $\text{A}^2\text{s}$ |       |
|   |               | $T_C = 115^\circ\text{C}$ , $t_p = 10\text{ ms}$   | 300   | $\text{A}^2\text{s}$ |       |

### Thermal Characteristics

|                                     |            |                         |      |                    |  |
|-------------------------------------|------------|-------------------------|------|--------------------|--|
| Thermal resistance, junction - case | $R_{thJC}$ | SiC Junction Transistor | 0.57 | $^\circ\text{C/W}$ |  |
| Thermal resistance, junction - case | $R_{thJC}$ | SiC Diode               | 0.53 | $^\circ\text{C/W}$ |  |

### Mechanical Properties

|                            | Symbol | Values |                |      | Unit | Notes |
|----------------------------|--------|--------|----------------|------|------|-------|
|                            |        | Min.   | Typical        | Max. |      |       |
| Mounting Torque            | $M_d$  |        | 1.5            |      | Nm   |       |
| Terminal Connection Torque |        | 1.3    |                | 1.5  | Nm   |       |
| Weight                     |        |        | 29             |      | g    |       |
| Case Color                 |        |        | Black          |      |      |       |
| Dimensions                 |        |        | 38 x 25.4 x 12 |      | mm   |       |

## Section II: Static Electrical Characteristics

| Parameter                        | Symbol       | Conditions   | Value |         |      | Unit          | Notes  |
|----------------------------------|--------------|--|-------|---------|------|---------------|--------|
|                                  |              |  | Min.  | Typical | Max. |               |        |
| <b>A: On State</b>               |              |  |       |         |      |               |        |
| Drain – Source On Resistance     | $R_{DS(ON)}$ | $I_D = 50\text{ A}$ , $T_J = 25^\circ\text{C}$                               |       | 20      |      | m $\Omega$    | Fig. 4 |
|                                  |              | $I_D = 50\text{ A}$ , $T_J = 150^\circ\text{C}$                              |       | 36      |      |               |        |
|                                  |              | $I_D = 50\text{ A}$ , $T_J = 175^\circ\text{C}$                              |       | 42      |      |               |        |
| Gate – Source Saturation Voltage | $V_{GS,SAT}$ | $I_D = 50\text{ A}$ , $I_D/I_G = 40$ , $T_J = 25^\circ\text{C}$              |       | 3.42    |      | V             | Fig. 7 |
|                                  |              | $I_D = 50\text{ A}$ , $I_D/I_G = 30$ , $T_J = 175^\circ\text{C}$             |       | 3.23    |      |               |        |
| DC Current Gain                  | $h_{FE}$     | $V_{DS} = 8\text{ V}$ , $I_D = 50\text{ A}$ , $T_J = 25^\circ\text{C}$       |       | 104     |      | –             | Fig. 5 |
|                                  |              | $V_{DS} = 8\text{ V}$ , $I_D = 50\text{ A}$ , $T_J = 125^\circ\text{C}$      |       | 65      |      |               |        |
|                                  |              | $V_{DS} = 8\text{ V}$ , $I_D = 50\text{ A}$ , $T_J = 175^\circ\text{C}$      |       | 58      |      |               |        |
| FWD forward voltage              | $V_F$        | $I_F = 50\text{ A}$ , $T_J = 25^\circ\text{C}$                               |       | 1.5     | 1.8  | V             |        |
|                                  |              | $I_F = 50\text{ A}$ , $T_J = 175^\circ\text{C}$                              |       | 2.4     | 3.0  |               |        |
| <b>B: Off State</b>              |              |  |       |         |      |               |        |
| Drain Leakage Current            | $I_{DSS}$    | $V_{DS} = 1200\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 25^\circ\text{C}$  |       | 50      | 1000 | $\mu\text{A}$ | Fig. 8 |
|                                  |              | $V_{DS} = 1200\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 150^\circ\text{C}$ |       | 100     |      |               |        |
|                                  |              | $V_{DS} = 1200\text{ V}$ , $V_{GS} = 0\text{ V}$ , $T_J = 175^\circ\text{C}$ |       | 200     |      |               |        |
| Gate Leakage Current             | $I_{SG}$     | $V_{SG} = 20\text{ V}$ , $T_J = 25^\circ\text{C}$                            |       | 20      |      | nA            |        |

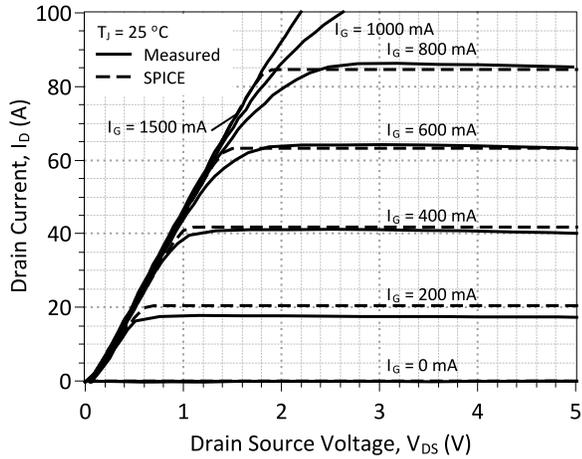
**Section III: Dynamic Electrical Characteristics**

| Parameter   | Symbol            | Conditions  | Value                |            |      | Unit          | Notes         |
|---|-------------------|---|----------------------|------------|------|---------------|---------------|
|   |                   |   | Min.                 | Typical    | Max. |               |               |
| <b>A: Capacitance and Gate Charge</b>               |                   |   |                      |            |      |               |               |
| Input Capacitance                                   | $C_{iss}$         | $V_{GS} = 0\text{ V}, V_{DS} = 800\text{ V}, f = 1\text{ MHz}$  |                      | 7209       |      | pF            | Fig. 9        |
| Reverse Transfer/Output Capacitance                 | $C_{rss}/C_{oss}$ | $V_{DS} = 800\text{ V}, f = 1\text{ MHz}$   |                      | 265        |      | pF            | Fig. 9        |
| Total FWD capacitance                               | $C_{FWD}$         | $V_R = 1\text{ V}, f = 1\text{ MHz}, T_j = 25\text{ }^\circ\text{C}$  |                      | 2940       |      | pF            |               |
|   |                   | $V_R = 400\text{ V}, f = 1\text{ MHz}, T_j = 25\text{ }^\circ\text{C}$<br>$V_R = 1000\text{ V}, f = 1\text{ MHz}, T_j = 25\text{ }^\circ\text{C}$ |                      | 203<br>142 |      |               |               |
| Output Capacitance Stored Energy                    | $E_{OSS}$         | $V_{GS} = 0\text{ V}, V_{DS} = 800\text{ V}, f = 1\text{ MHz}$  |                      | 112        |      | $\mu\text{J}$ | Fig. 10       |
| Effective Output Capacitance, time related          | $C_{oss,tr}$      | $I_D = \text{constant}, V_{GS} = 0\text{ V}, V_{DS} = 0\dots 800\text{ V}$  |                      | 524        |      | pF            |               |
| Effective Output Capacitance, energy related        | $C_{oss,er}$      | $V_{GS} = 0\text{ V}, V_{DS} = 0\dots 800\text{ V}$   |                      | 357        |      | pF            |               |
| Gate-Source Charge                                  | $Q_{GS}$          | $V_{GS} = -5\dots 3\text{ V}$   |                      | 55         |      | nC            |               |
| Gate-Drain Charge                                   | $Q_{GD}$          | $V_{GS} = 0\text{ V}, V_{DS} = 0\dots 800\text{ V}$   |                      | 419        |      | nC            |               |
| Gate Charge - Total                                 | $Q_G$             |   |                      | 474        |      | nC            |               |
| Total FWD capacitive charge                         | $Q_{C,FWD}$       | $I_F \leq I_{F,MAX}$<br>$di_F/dt = 200\text{ A}/\mu\text{s}$<br>$T_j = 175\text{ }^\circ\text{C}$   | $V_R = 400\text{ V}$ | 158        |      | nC            |               |
|   |                   |   | $V_R = 960\text{ V}$ | 247        |      |               |               |
| <b>B: SJT Switching Characteristics<sup>1</sup></b> |                   |   |                      |            |      |               |               |
| Internal Gate Resistance – zero bias                | $R_{G(INT-ZERO)}$ | $f = 1\text{ MHz}, V_{AC} = 50\text{ mV}, V_{DS} = 0\text{ V}, V_{GS} = 0\text{ V}, T_j = 175\text{ }^\circ\text{C}$                              |                      | 0.58       |      | $\Omega$      |               |
| Internal Gate Resistance – ON                       | $R_{G(INT-ON)}$   | $V_{GS} > 2.5\text{ V}, V_{DS} = 0\text{ V}, T_j = 175\text{ }^\circ\text{C}$   |                      | 0.09       |      | $\Omega$      |               |
| Turn On Delay Time                                  | $t_{d(on)}$       | $T_j = 25\text{ }^\circ\text{C}, V_{DS} = 750\text{ V}, I_D = 30\text{ A}, \text{ Inductive Load}$  |                      | 25         |      | ns            |               |
| Fall Time, $V_{DS}$                                 | $t_f$             | Refer to Section V for additional driving information.  |                      | 60         |      | ns            |               |
| Turn Off Delay Time                                 | $t_{d(off)}$      |   |                      | 80         |      | ns            |               |
| Rise Time, $V_{DS}$                                 | $t_r$             |   |                      | 50         |      | ns            |               |
| Turn-On Energy Per Pulse                            | $E_{on}$          | $T_j = 25\text{ }^\circ\text{C}, V_{DS} = 750\text{ V}, I_D = 30\text{ A}, \text{ Inductive Load}$  |                      | 650        |      | $\mu\text{J}$ |               |
| Turn-Off Energy Per Pulse                           | $E_{off}$         | Refer to Section V.   |                      | 525        |      | $\mu\text{J}$ |               |
| Total Switching Energy                              | $E_{tot}$         |   |                      |            | 1175 |               | $\mu\text{J}$ |

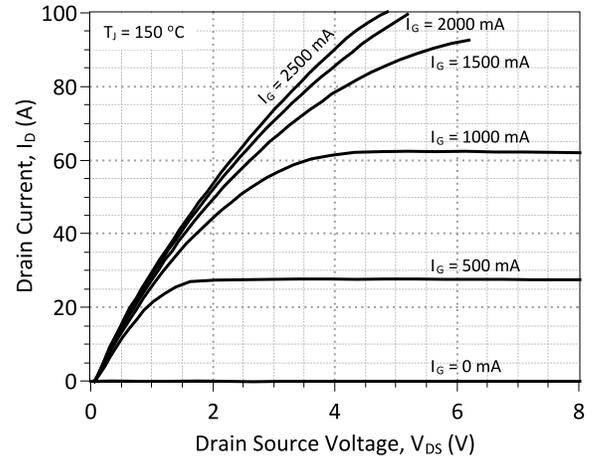
<sup>1</sup> – All times are relative to the Drain-Source Voltage  $V_{DS}$

**Section IV: Figures**

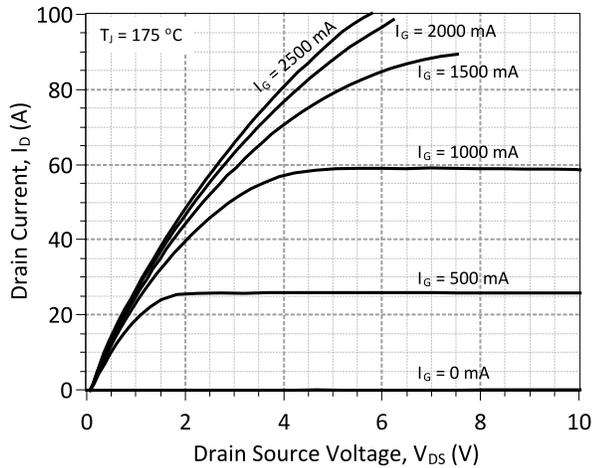
**A: Static Characteristics**



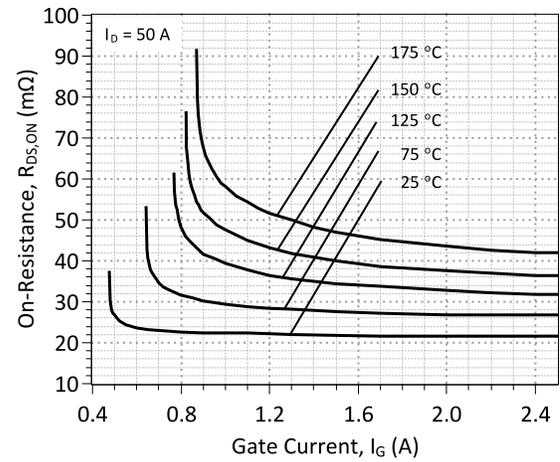
**Figure 1: Typical Output Characteristics at 25 °C**



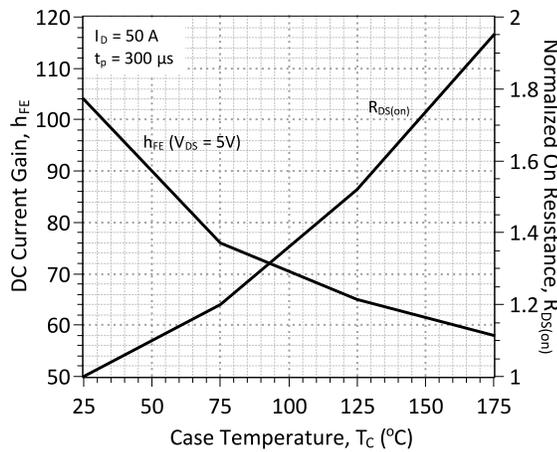
**Figure 2: Typical Output Characteristics at 150 °C**



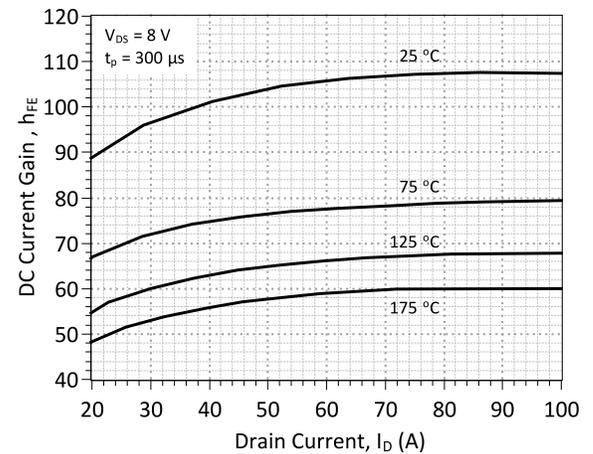
**Figure 3: Typical Output Characteristics at 175 °C**



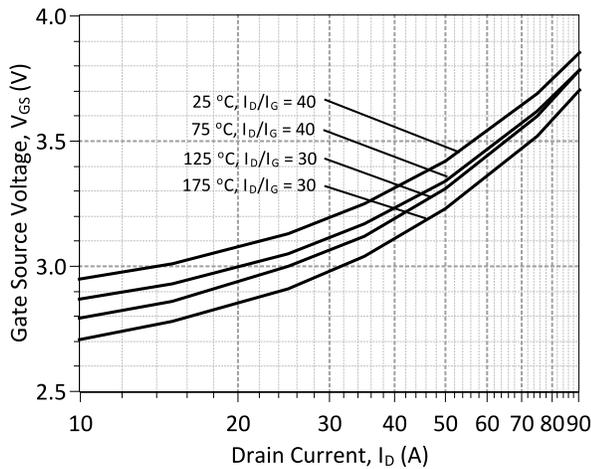
**Figure 4: On-Resistance vs. Gate Current**



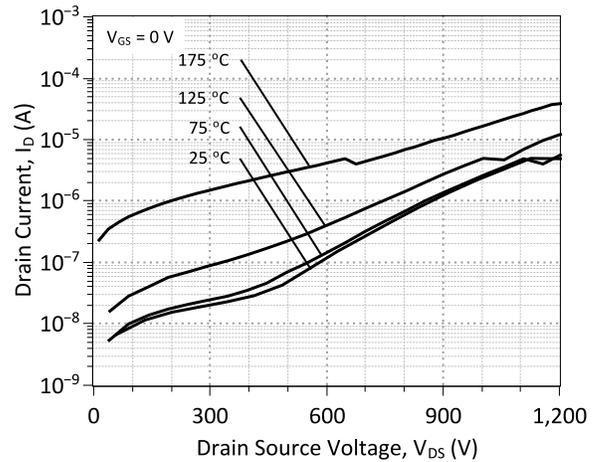
**Figure 5: DC Current Gain and Normalized On-Resistance vs. Temperature**



**Figure 6: DC Current Gain vs. Drain Current**

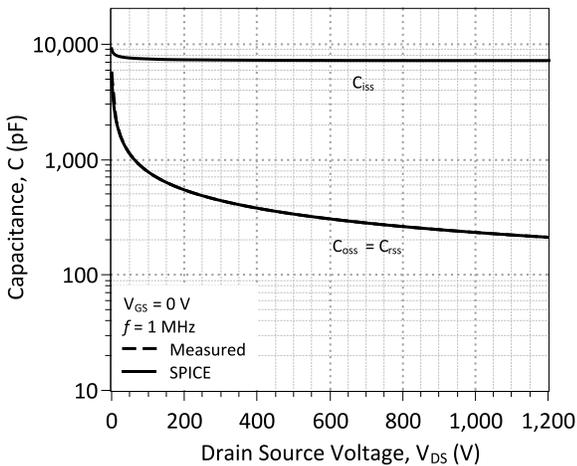


**Figure 7: Typical Gate – Source Saturation Voltage**

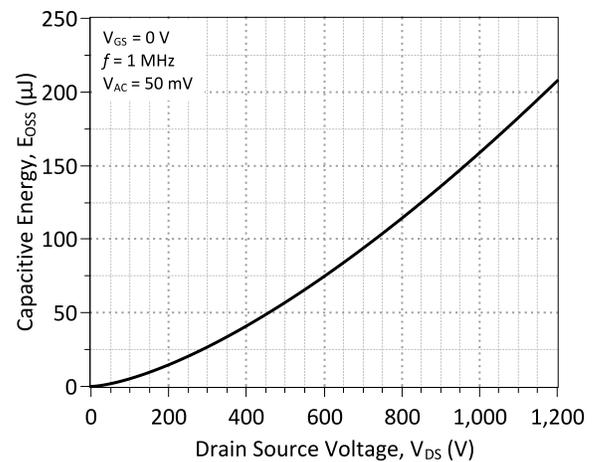


**Figure 8: Typical Blocking Characteristics**

**B: Dynamic Characteristics**

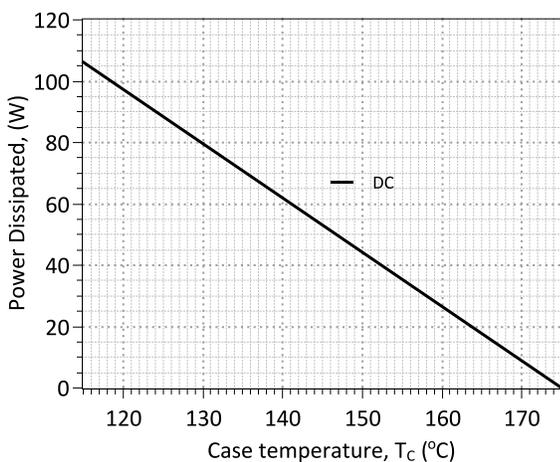


**Figure 9: Input, Output, and Reverse Transfer Capacitance**

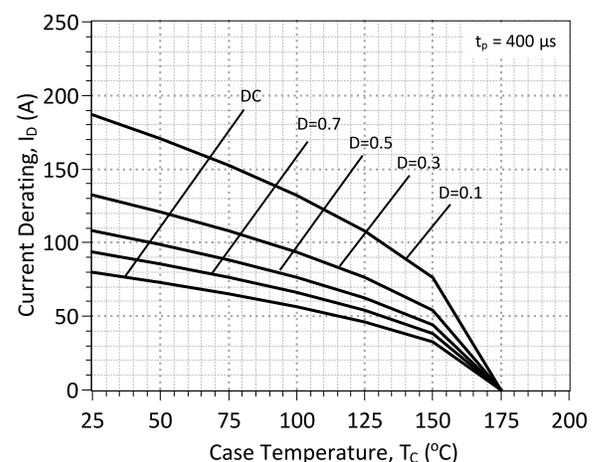


**Figure 10: Energy Stored in Output Capacitance**

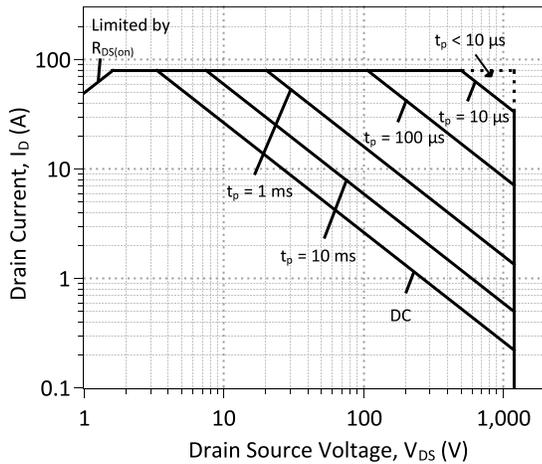
**C: Current and Power Derating**



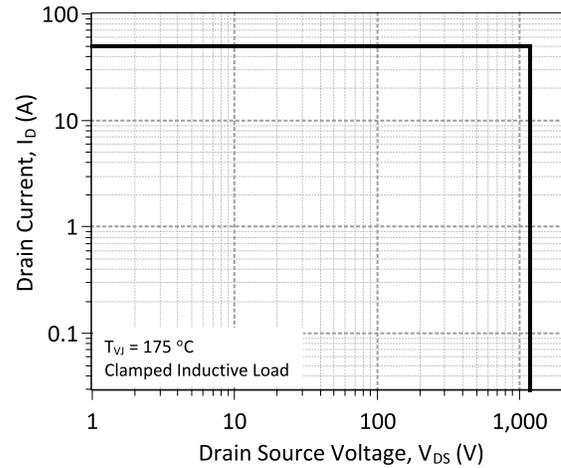
**Figure 11: Power Derating Curve**



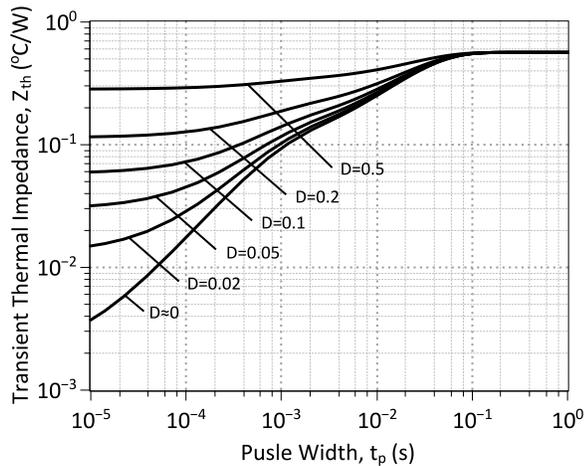
**Figure 12: Drain Current Derating vs. Temperature**



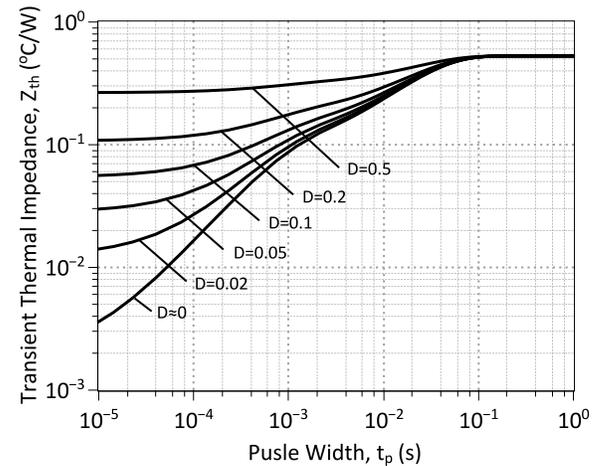
**Figure 13: Forward Bias Safe Operating Area at  $T_c = 25\text{ }^\circ\text{C}$**



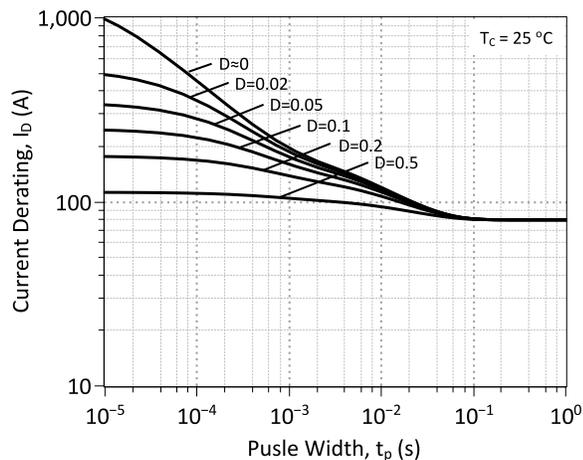
**Figure 14: Turn-Off Safe Operating Area**



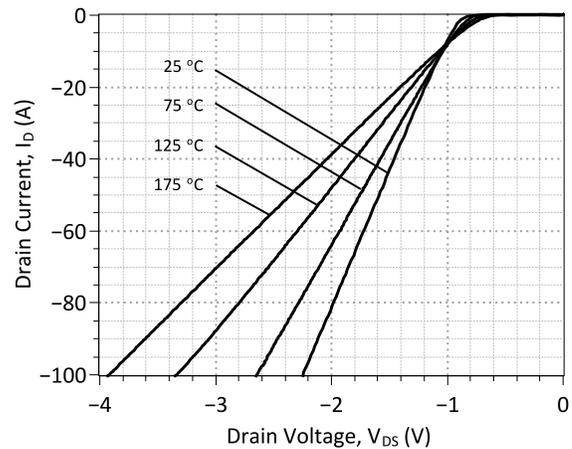
**Figure 15: SJT Transient Thermal Impedance**



**Figure 16: FWD Transient Thermal Impedance**



**Figure 17: Drain Current Derating vs. Pulse Width**



**Figure 18: Typical FWD Forward Characteristics**

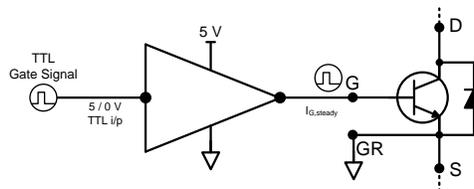
**Section V: Driving the GA50SICP12-227**

| Drive Topology               | Gate Drive Power Consumption | Switching Frequency | Application Emphasis     | Availability |
|------------------------------|------------------------------|---------------------|--------------------------|--------------|
| TTL Logic                    | High                         | Low                 | Wide Temperature Range   | Coming Soon  |
| Constant Current             | Medium                       | Medium              | Wide Temperature Range   | Coming Soon  |
| High Speed – Boost Capacitor | Medium                       | High                | Fast Switching           | Production   |
| High Speed – Boost Inductor  | Low                          | High                | Ultra Fast Switching     | Coming Soon  |
| Proportional                 | Lowest                       | High                | Wide Drain Current Range | Coming Soon  |
| Pulsed Power                 | Medium                       | N/A                 | Pulse Power              | Coming Soon  |

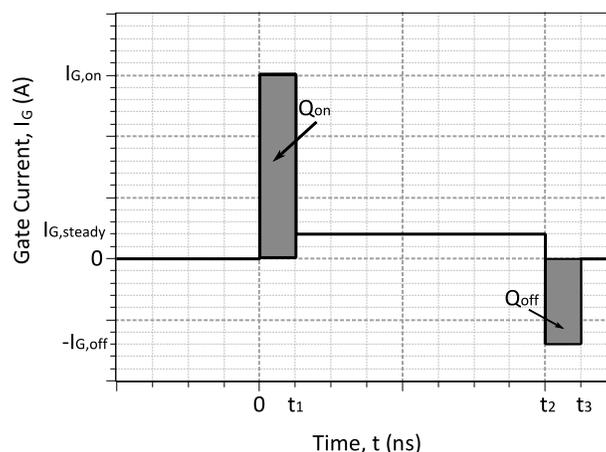
**A: Static TTL Logic Driving**

The GA50SICP12-227 may be driven using direct (5 V) TTL logic after current amplification. The (amplified) current level of the supply must meet or exceed the steady state gate current ( $I_{G,steady}$ ) required to operate the GA50SICP12-227. The power level of the supply can be estimated from the target duty cycle of the particular application.  $I_{G,steady}$  is dependent on the anticipated drain current  $I_D$  through the SJT and the DC current gain  $h_{FE}$ , it may be calculated from the following equation. An accurate value of the  $h_{FE}$  may be read from Figure 6.

$$I_{G,steady} \approx \frac{I_D}{h_{FE}(T, I_D)} * 1.5$$


**Figure 19: TTL Gate Drive Schematic**
**B: High Speed Driving**

The SJT is a current controlled transistor which requires a positive gate current for turn-on as well as to remain in on-state. An ideal gate current waveform for ultra-fast switching of the SJT, while maintaining low gate drive losses, is shown in Figure 20 which features a positive current peak during turn-on, a negative current peak during turn-off, and continuous gate current to remain on.


**Figure 20: An idealized gate current waveform for fast switching of an SJT.**

An SJT is rapidly switched from its blocking state to on-state, when the necessary gate charge,  $Q_G$ , for turn-on is supplied by a burst of high gate current,  $I_{G,on}$ , until the gate-source capacitance,  $C_{GS}$ , and gate-drain capacitance,  $C_{GD}$ , are fully charged.

$$Q_{on} = I_{G,on} * t_1$$

$$Q_{on} \geq Q_{gs} + Q_{gd}$$

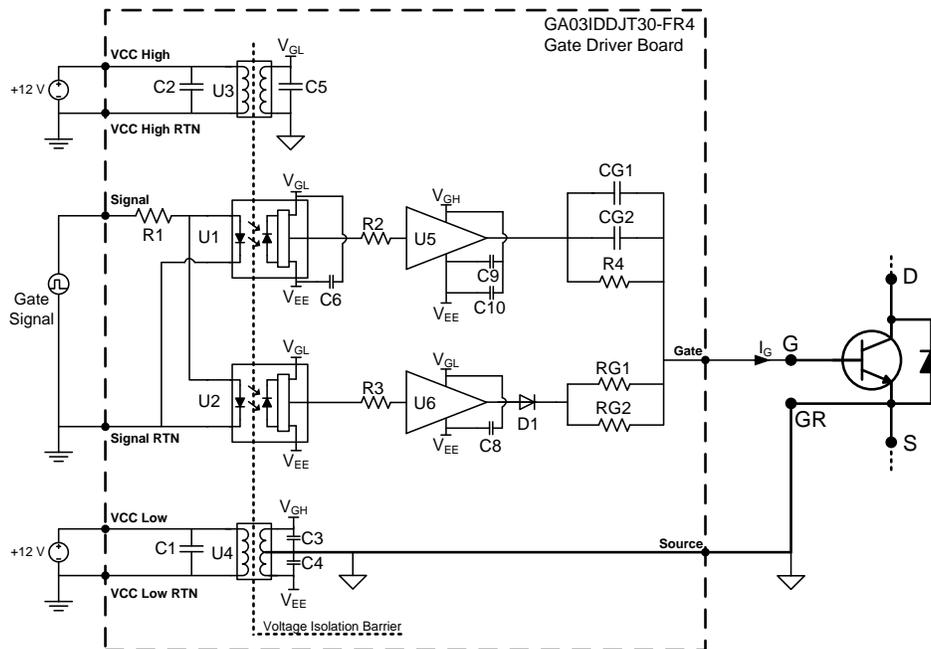
Ideally,  $I_{G,on}$  should terminate when the drain voltage falls to its on-state value in order to avoid unnecessary drive losses during the steady on-state. In practice, the rise time of the  $I_{G,on}$  pulse is affected by the parasitic inductances,  $L_{par}$  in the device package and drive circuit. A voltage developed across the parasitic inductance in the source path,  $L_s$ , can de-bias the gate-source junction, when high drain currents begin to flow through the device. The voltage applied to the gate pin should be maintained high enough, above the  $V_{GS,sat}$  (see Figure 7) level to counter these effects.

A high negative peak current,  $-I_{G,off}$  is recommended at the start of the turn-off transition, in order to rapidly sweep out the injected carriers from the gate, and achieve rapid turn-off. While satisfactory turn off can be achieved with  $V_{GS} = 0$  V, a negative gate voltage  $V_{GS}$  may be used in order to speed up the turn-off transition.

Two high-speed drive topologies for the SiC SJs are presented below.

**B:1: High Speed, Low Loss Drive with Boost Capacitor, GA03IDDJT30-FR4**

The GA50SICP12-227 may be driven using a High Speed, Low Loss Drive with Boost Capacitor topology in which multiple voltage levels, a gate resistor, and a gate capacitor are used to provide fast switching current peaks at turn-on and turn-off and a continuous gate current while in on-state. A 3 kV isolated evaluation gate drive board (GA03IDDJT30-FR4) utilizing this topology is commercially available for high and low-side driving, its datasheet provides additional details about this drive topology.



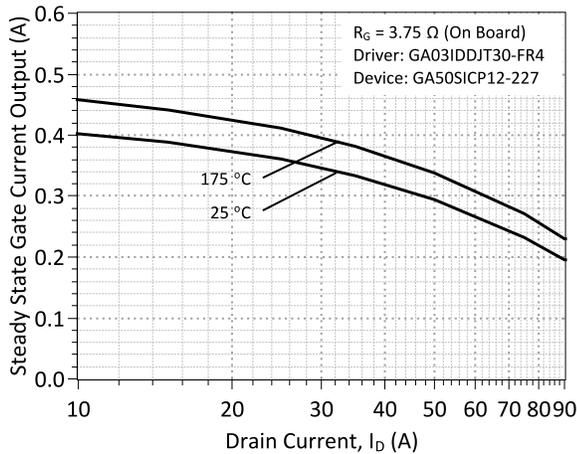
**Figure 21: Topology of the GA03IDDJT30-FR4 Two Voltage Source gate driver.**

The GA03IDDJT30-FR4 evaluation board comes equipped with two on board gate drive resistors (RG1, RG2) pre-installed for an effective gate resistance<sup>3</sup> of  $R_G = 3.75 \Omega$ . It may be necessary for the user to reduce RG1 and RG2 under high drain current conditions for safe operation of the GA50SICP12-227. The steady state current supplied to the gate pin of the GA50SICP12-227 with on-board  $R_G = 3.75 \Omega$ , is shown in Figure 22. The maximum allowable safe value of  $R_G$  for the user's required drain current can be read from Figure 23.

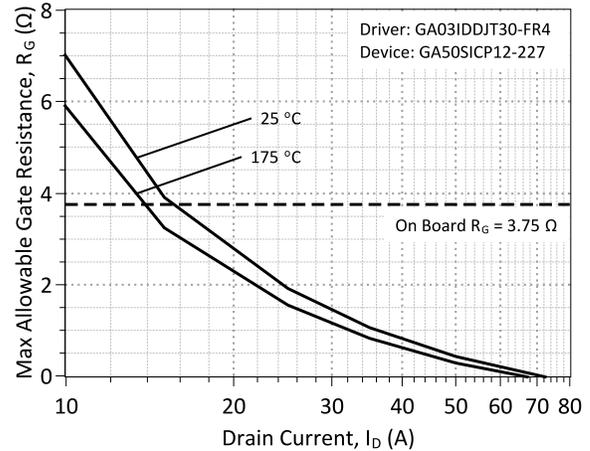
**For the GA50SICP12-227,  $R_G$  must be reduced for  $I_D \geq \sim 14$  A for safe operation with the GA03IDDJT30-FR4.**

For operation at  $I_D \geq \sim 14$  A,  $R_G$  may be calculated from the following equation, which contains the DC current gain  $h_{FE}$  (Figure 6) and the gate-source saturation voltage  $V_{GS,sat}$  (Figure 7).

$$R_{G,max} = \frac{(4.7V - V_{GS,sat}) * h_{FE}(T, I_D)}{I_D * 1.5} - 0.6\Omega$$



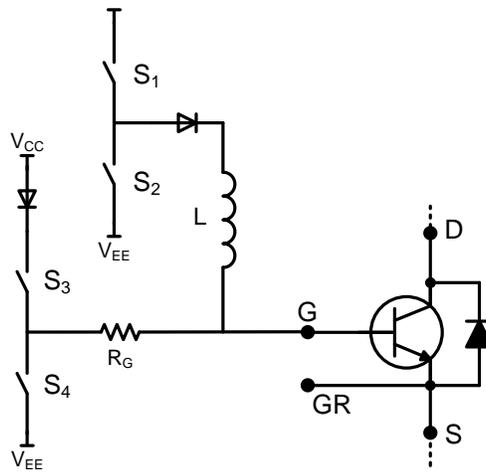
**Figure 22: Typical steady state gate current supplied by the GA03IDDJT30-FR4 board for the GA50SICP12-227 with the on board resistance of 3.75 Ω**



**Figure 23: Maximum gate resistance for safe operation of the GA50SICP12-227 at different drain currents using the GA03IDDJT30-FR4 board.**

**B:2: High Speed, Low Loss Drive with Boost Inductor**

A High Speed, Low-Loss Driver with Boost Inductor is also capable of driving the GA50SICP12-227 at high-speed. It utilizes a gate drive inductor instead of a capacitor to provide the high-current gate current pulses  $I_{G,on}$  and  $I_{G,off}$ . During operation, inductor L is charged to a specified  $I_{G,on}$  current value then made to discharge  $I_L$  into the SJT gate pin using logic control of  $S_1$ ,  $S_2$ ,  $S_3$ , and  $S_4$ , as shown in Figure 24. After turn on, while the device remains on the necessary steady state gate current  $I_{G,steady}$  is supplied from source  $V_{CC}$  through  $R_G$ . Please refer to the article “A current-source concept for fast and efficient driving of silicon carbide transistors” by Dr. Jacek Rąbkowski for additional information on this driving topology.<sup>4</sup>



**Figure 24: Simplified Inductive Pulsed Drive Topology**

<sup>3</sup> –  $R_G = (1/R_{G1} + 1/R_{G2})^{-1}$ . Driver is pre-installed with  $R_{G1} = R_{G2} = 7.5 \Omega$

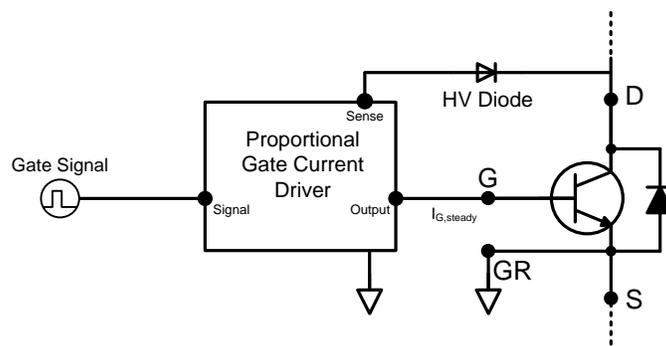
<sup>4</sup> – Archives of Electrical Engineering. Volume 62, Issue 2, Pages 333–343, ISSN (Print) 0004-0746, DOI: 10.2478/ae-2013-0026, June 2013

**C: Proportional Gate Current Driving**

For applications in which the GA50SICP12-227 will operate over a wide range of drain current conditions, it may be beneficial to drive the device using a proportional gate drive topology to optimize gate drive power consumption. A proportional gate driver relies on instantaneous drain current  $I_D$  feedback to vary the steady state gate current  $I_{G,steady}$  supplied to the GA50SICP12-227

**C:1: Voltage Controlled Proportional Driver**

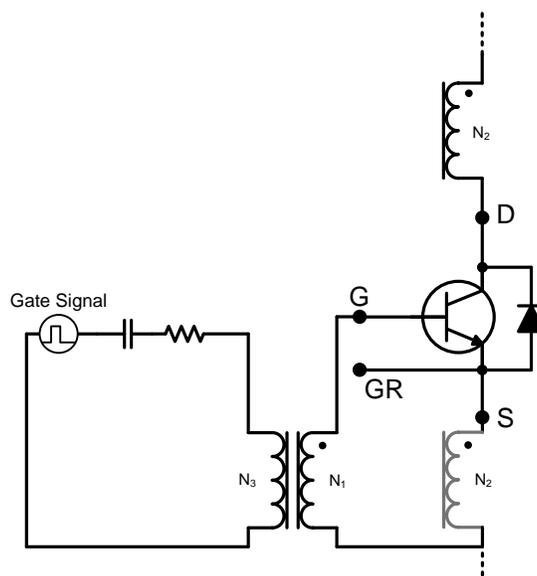
The voltage controlled proportional driver relies on a gate drive IC to detect the GA50SICP12-227 drain-source voltage  $V_{DS}$  during on-state to sense  $I_D$ . The gate drive IC will then increase or decrease  $I_{G,steady}$  in response to  $I_D$ . This allows  $I_{G,steady}$ , and thus the gate drive power consumption, to be reduced while  $I_D$  is relatively low or for  $I_{G,steady}$  to increase when is  $I_D$  higher. A high voltage diode connected between the drain and sense protects the IC from high-voltage when the driver and GA50SICP12-227 are in off-state. A simplified version of this topology is shown in Figure 25, additional information will be available in the future at <http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/>



**Figure 25: Simplified Voltage Controlled Proportional Driver**

**C:2: Current Controlled Proportional Driver**

The current controlled proportional driver relies on a low-loss transformer in the drain or source path to provide feedback  $I_D$  of the GA50SICP12-227 during on-state to supply  $I_{G,steady}$  into the device gate.  $I_{G,steady}$  will then increase or decrease in response to  $I_D$  at a fixed forced current gain which is set by the turns ratio of the transformer,  $n_{force} = I_D / I_G = N_2 / N_1$ . GA50SICP12-227 is initially tuned-on using a gate current pulse supplied into an RC drive circuit to allow  $I_D$  current to begin flowing. This topology allows  $I_{G,steady}$ , and thus the gate drive power consumption, to be reduced while  $I_D$  is relatively low or for  $I_{G,steady}$  to increase when is  $I_D$  higher. A simplified version of this topology is shown in Figure 26, additional information will be available in the future at <http://www.genesicsemi.com/commercial-sic/sic-junction-transistors/>.

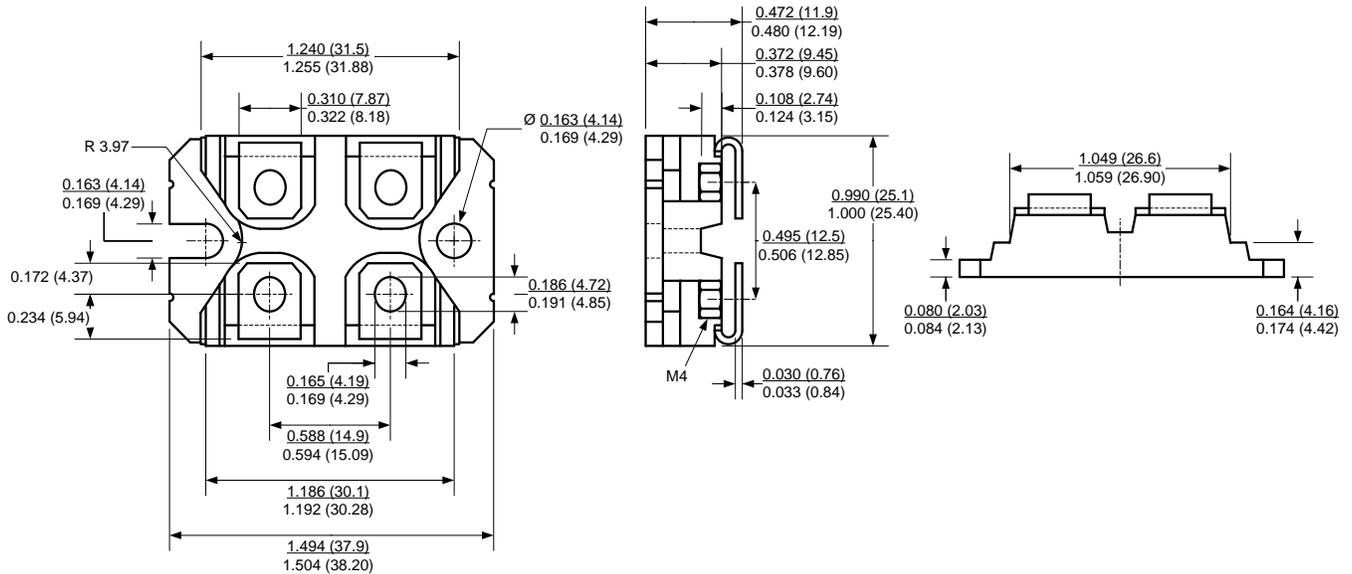


**Figure 26: Simplified Current Controlled Proportional Driver**

Section VI: Package Dimensions

SOT-227

PACKAGE OUTLINE



NOTE

1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS

| Revision History |          |                 |            |
|------------------|----------|-----------------|------------|
| Date             | Revision | Comments        | Supersedes |
| 2015/03/26       | 0        | Initial release |            |

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**Section VII: SPICE Model Parameters**

This is a secure document. Please copy this code from the SPICE model PDF file on our website ([http://www.genesicsemi.com/images/products\\_sic/igbt\\_copack/GA50SICP12-227\\_spice.pdf](http://www.genesicsemi.com/images/products_sic/igbt_copack/GA50SICP12-227_spice.pdf)) into LTSPICE (version 4) software for simulation of the GA50SICP12-227.

```

*      MODEL OF GeneSiC Semiconductor Inc.
*      $Revision: 1.0          $
*      $Date:      26-MAR-2015    $
*
*      GeneSiC Semiconductor Inc.
*      43670 Trade Center Place Ste. 155
*      Dulles, VA 20166
*
*      COPYRIGHT (C) 2014 GeneSiC Semiconductor Inc.
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*      These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
*      OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
*      TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
*      PARTICULAR PURPOSE."
*      Models accurate up to 2 times rated drain current.
*
*      Start of GA50SICP12-227 SPICE Model
*
.SUBCKT GA50SIPC12 DRAIN GATE SOURCE
Q1 DRAIN GATE SOURCE GA50SIPC12_Q
D1 SOURCE DRAIN GA50SIPC12_D1
D2 SOURCE DRAIN GA50SIPC12_D2
*
.model GA50SIPC12_Q NPN
+ IS      9.833E-48      ISE      1.073E-26      EG      3.23
+ BF      110           BR       0.55           IKF     9000
+ NF      1             NE       2            RB      0.95
+ RE      0.005         RC       0.014         CJC     2.398E-9
+ VJC     2.8346        MJC     0.4846        CJE     6.026E-09
+ VJE     3.1791        MJE     0.5295        XTI     3
+ XTB     -1.5          TRC1    9.0E-03        MFG     GeneSiC_Semi
+ IRB     0.005         RBM     0.073
.MODEL GA50SIPC12_D1 D
+ IS      1.99E-16      RS      0.015652965    N       1
+ IKF     1000          EG      1.2             XTI     3
+ TRS1    0.0042        TRS2    1.3E-05         CJO     3.86E-09
+ VJ      1.362328465   M       0.48198551       FC      0.5
+ TT      1.00E-10      IAVE    50
.MODEL GA50SIPC12_D2 D
+ IS      1.54E-19      RS      0.1           N       3.941
+ EG      3.23          TRS1    -0.004          IKF     19
+ XTI     0             FC      0.5            TT      0
.ENDS
*      End of GA50SICP12-227 SPICE Model

```